

Product Summary

V_{(BR)DSS}	R_{DS(ON)} max	I_D max T_A = +25°C
-40V	80mΩ @ V _{GS} = -10V	-3.7 A
	150mΩ @ V _{GS} = -4.5V	-2.8 A

Description

This MOSFET has been designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Motor Control
- DC-DC Converters
- Power Management Functions
- Uninterrupted Power Supply

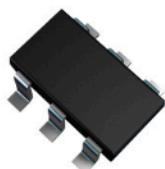
Features and Benefits

- Fast switching speed
- Low gate drive
- Low input capacitance
- **Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**
- **Qualified to AEC-Q101 Standards for High Reliability**
- **PPAP Capable (Note 4)**

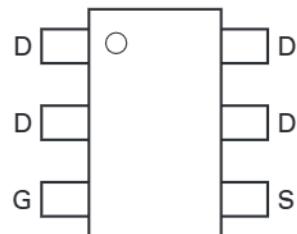
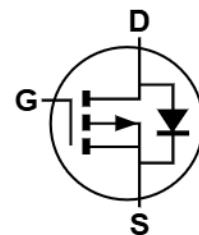
Mechanical Data

- Case: SOT26
- Case Material: Molded Plastic, UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish - Matte Tin annealed over Copper lead frame. Solderable per MIL-STD-202, Method 208 **(e3)**
- Weight 0.018 grams (approximate)

SOT26



Top View


 Top View
Pin-Out


Equivalent Circuit

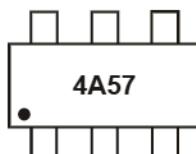
Ordering Information (Note 4 & 5)

Part Number	Compliance	Case	Quantity per reel
ZXMP4A57E6TA	Standard	SOT26	3,000
ZXMP4A57E6QTA	Automotive	SOT26	3,000

Notes:

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
4. Automotive products are AEC-Q101 qualified and are PPAP capable. Automotive, AEC-Q101 and standard products are electrically and thermally the same, except where specified. For more information, please refer to http://www.diodes.com/quality/product_grade_definitions/.
5. For packaging details, go to our website at <http://www.diodes.com/products/packages.html>.

Marking Information



4A57 = Product Type Marking Code

Maximum Ratings (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Drain-Source Voltage		V_{DSS}	-40	V	
Gate-Source Voltage		V_{GS}	± 20	V	
Continuous Drain Current	$V_{GS} = 10\text{V}$	(Note 7)	-3.7	A	
		$T_A = +70^\circ\text{C}$ (Note 7)	-2.9		
		(Note 6)	-2.9		
Pulsed Drain current	$V_{GS} = 10\text{V}$	(Note 8)	I_{DM}	-18	A
Continuous Source Current (Body Diode)		(Note 7)	I_S	-2.6	A
Pulsed Source Current (Body Diode)		(Note 8)	I_{SM}	-18	A

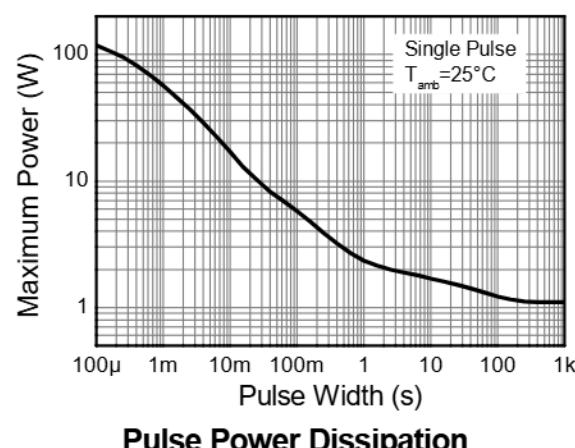
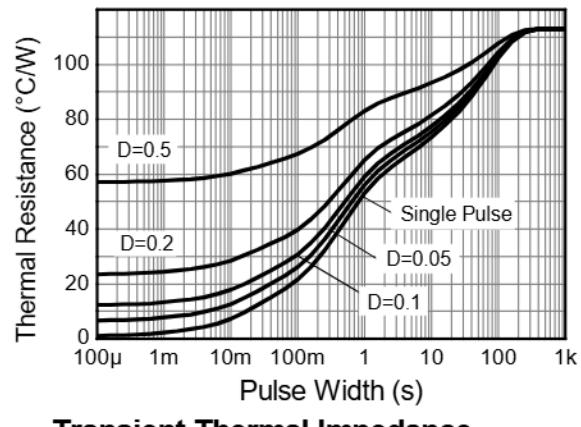
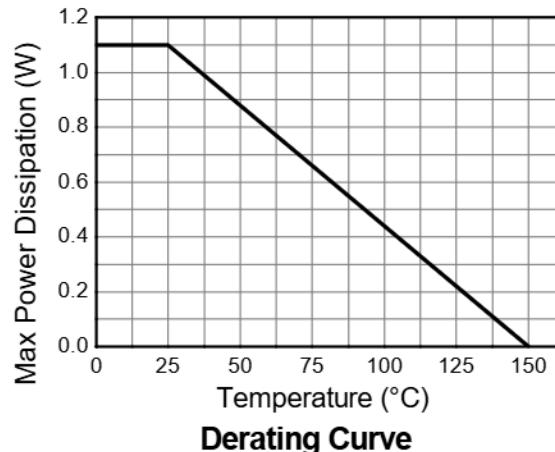
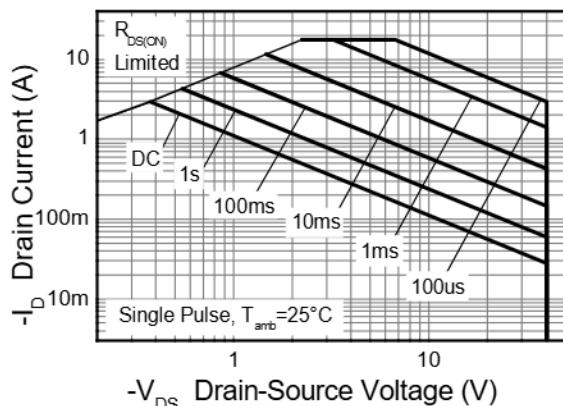
Thermal Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Power dissipation Linear derating factor	(Note 6)	P_D	1.1	W mW/ $^\circ\text{C}$
	(Note 7)		8.8	
	(Note 6)		1.7	
	(Note 7)		13.7	
Thermal Resistance, Junction to Ambient		$R_{\theta JA}$	113	$^\circ\text{C/W}$
			73	
Operating and storage temperature range		T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

Notes:

- 6. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 7. Same as note (4), except the device is measured at $t \leq 5$ sec.
- 8. Same as note (4), except the device is pulsed with $D = 0.02$ and pulse width 300 μs . The pulse current is limited by the maximum junction temperature.

Thermal Characteristics



Electrical Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

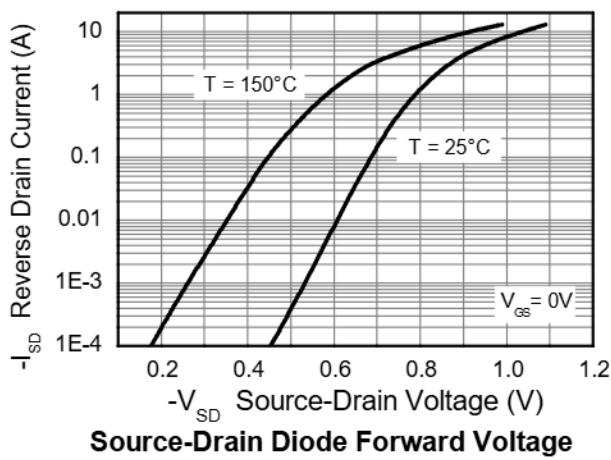
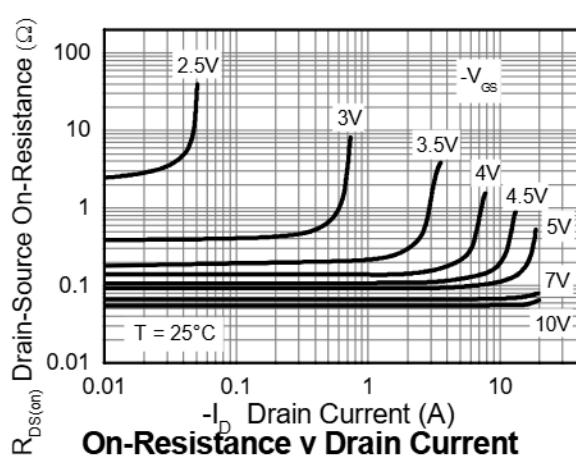
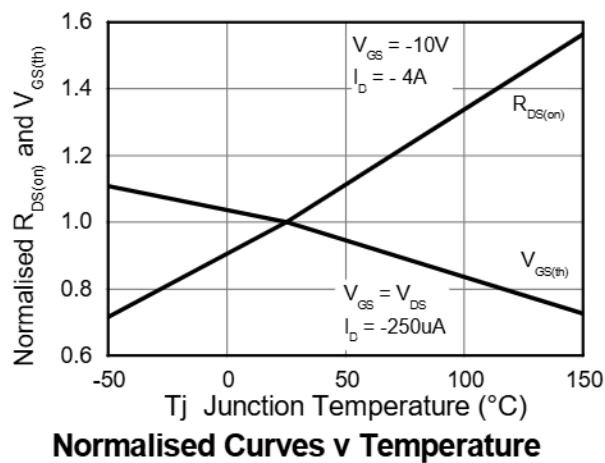
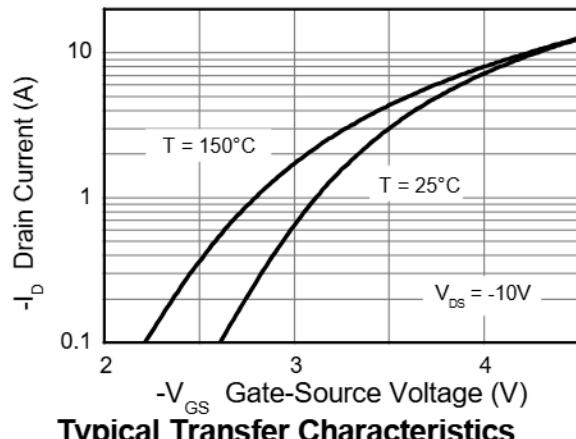
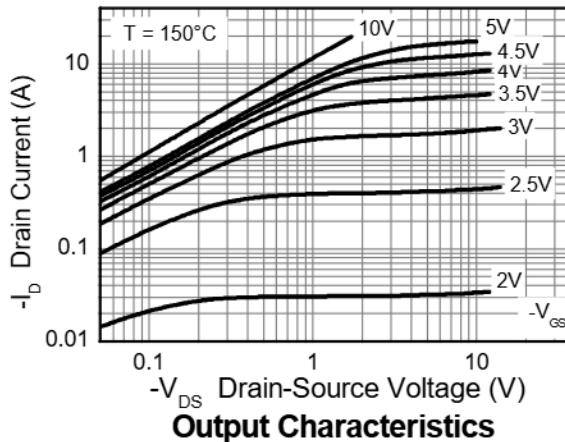
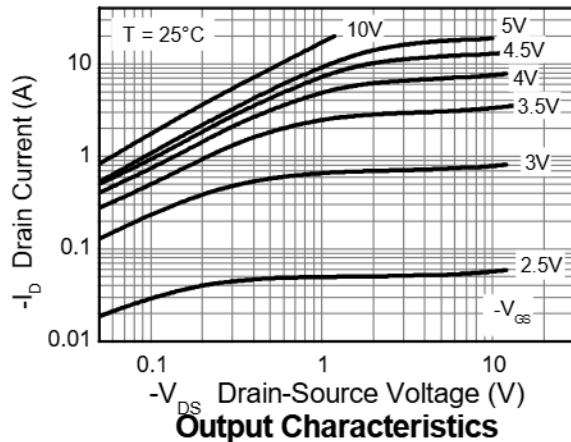
Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	-40	—	—	V	$I_D = -250\mu\text{A}$, $V_{GS} = 0\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}	—	—	-0.5	μA	$V_{DS} = -40\text{V}$, $V_{GS} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	—	—	± 100	nA	$V_{GS} = \pm 20\text{V}$, $V_{DS} = 0\text{V}$
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(\text{th})}$	-1.0	—	-3.0	V	$I_D = -250\mu\text{A}$, $V_{DS} = V_{GS}$
Static Drain-Source On-Resistance (Note 9)	$R_{DS(\text{ON})}$	—	—	0.080	Ω	$V_{GS} = -10\text{V}$, $I_D = -4\text{A}$
		—	—	0.150		$V_{GS} = -4.5\text{V}$, $I_D = -2\text{A}$
Forward Transconductance (Notes 9 & 10)	g_{fs}	—	7.6	—	S	$V_{DS} = -15\text{V}$, $I_D = -4\text{A}$
Diode Forward Voltage (Note 9)	V_{SD}	—	-0.86	-0.95	V	$I_S = -4\text{A}$, $V_{GS} = 0\text{V}$
Reverse recovery time (Note 10)	t_{rr}	—	17.4	—	ns	$I_S = -1.8\text{A}$, $di/dt = 100\text{A}/\mu\text{s}$
Reverse recovery charge (Note 10)	Q_{rr}	—	11.1	—	nC	
DYNAMIC CHARACTERISTICS (Note 10)						
Input Capacitance	C_{iss}	—	833	—	pF	$V_{DS} = -20\text{V}$, $V_{GS} = 0\text{V}$ $f = 1\text{MHz}$
Output Capacitance	C_{oss}	—	122	—		
Reverse Transfer Capacitance	C_{rss}	—	78	—		
Total Gate Charge (Note 11)	Q_g	—	7	—	nC	$V_{GS} = -4.5\text{V}$
Total Gate Charge (Note 11)	Q_g	—	15.8	—		$V_{DS} = -20\text{V}$
Gate-Source Charge (Note 11)	Q_{gs}	—	3.6	—		$V_{GS} = -10\text{V}$
Gate-Drain Charge (Note 11)	Q_{gd}	—	2.7	—		$I_D = -4\text{A}$
Turn-On Delay Time (Note 11)	$t_{D(\text{on})}$	—	2.5	—	ns	$V_{DD} = -20\text{V}$, $V_{GS} = -10\text{V}$ $I_D = -1\text{A}$, $R_G \geq 6.0\Omega$
Turn-On Rise Time (Note 11)	t_r	—	3.3	—		
Turn-Off Delay Time (Note 11)	$t_{D(\text{off})}$	—	47	—		
Turn-Off Fall Time (Note 11)	t_f	—	21	—		

Notes: 9. Measured under pulsed conditions. Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.

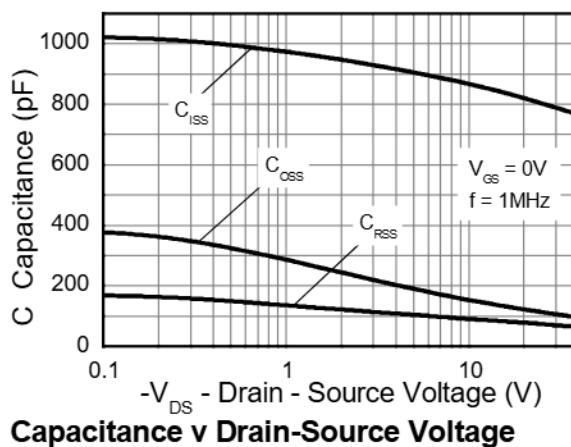
10. For design aid only, not subject to production testing.

11. Switching characteristics are independent of operating junction temperatures.

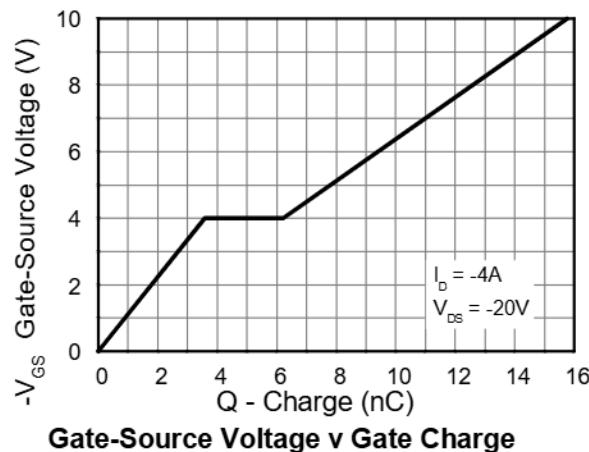
Typical Characteristics



Typical Characteristics (cont.)

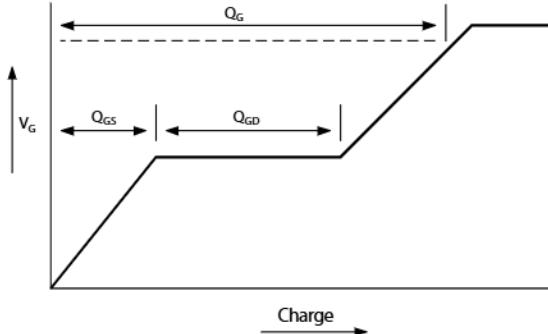


Capacitance v Drain-Source Voltage

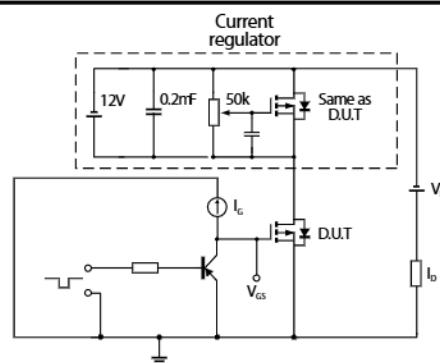


Gate-Source Voltage v Gate Charge

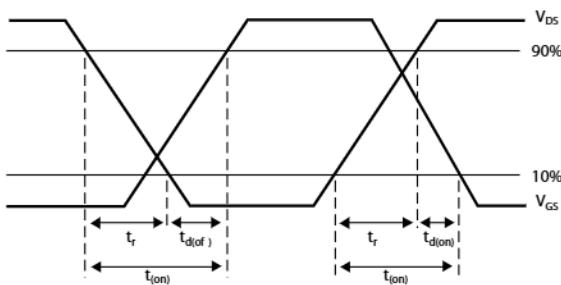
Test Circuits



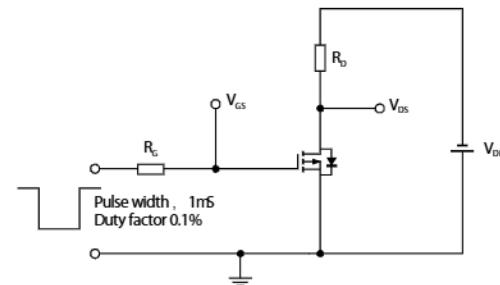
Basic gate charge waveform



Gate charge test circuit



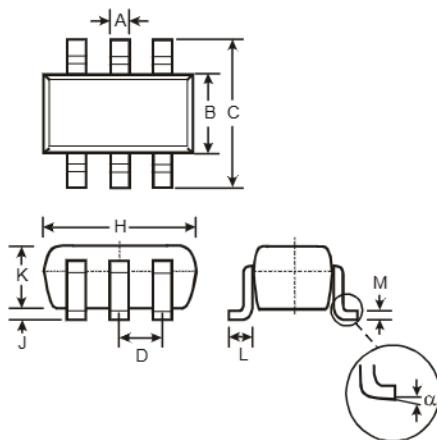
Switching time waveforms



Switching time test circuit

Package Outline Dimensions

Please see AP02002 at <http://www.diodes.com/datasheets/ap02002.pdf> for latest version.

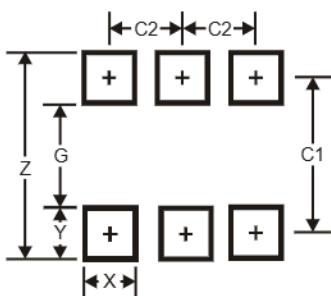


SOT26			
Dim	Min	Max	Typ
A	0.35	0.50	0.38
B	1.50	1.70	1.60
C	2.70	3.00	2.80
D	—	—	0.95
H	2.90	3.10	3.00
J	0.013	0.10	0.05
K	1.00	1.30	1.10
L	0.35	0.55	0.40
M	0.10	0.20	0.15
α	0°	8°	—

All Dimensions in mm

Suggested Pad Layout

Please see AP02001 at <http://www.diodes.com/datasheets/ap02001.pdf> for latest version.



Dimensions	Value (in mm)
Z	3.20
G	1.60
X	0.55
Y	0.80
C1	2.40
C2	0.95

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